

Notice of References Cited	Application/Control No. 09/829,151		Applicant(s)/Patent Under Reexamination YOUNG, ALAN	
	Examiner Tan Dean D. Nguyen		Art Unit 3689	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,393,415	05-2002	Getchius et al.	707/2
*	B	US-2004/0199445	10-2004	Eder, Jeff Scott	705/035
*	C	US-6,539,392	03-2003	Rebane, George J.	707/101
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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